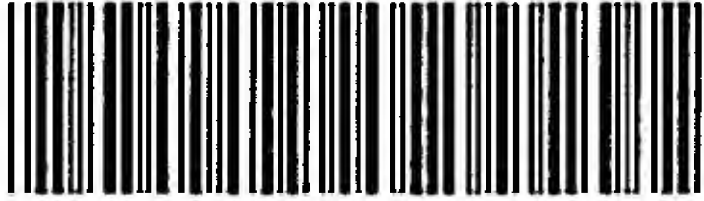


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/912,315	KOBAYASHI ET AL.	
	Examiner	Art Unit	
	Kevin M. Nguyen	2674	

SEARCHED			
Class	Subclass	Date	Examiner
update	searcj	12/1/2005	KMN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference claim search, see search history printout.		12/1/2005	KMN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search and inventor search, see search history printout.	12/1/2005	KMN